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MULTILAYER CERAMIC CAPACITORS



REFLOW

AEC-200

PART NUMBER

J	M	K	3	1	6	△	B	J	1	0	6	M	L	H	T	△
①	②	③	④	⑤	⑥	⑦	⑧	⑨	⑩	⑪	⑫					

△ = Blank space

① Rated voltage

Code	Rated voltage [VDC]
A	4
J	6.3
L	10
E	16
T	25
G	35
U	50
H	100
Q	250
S	630

② Series name

Code	Series name
M	Multilayer ceramic capacitor
V	Multilayer ceramic capacitor for high frequency
W	LW reverse type multilayer capacitor

③ End termination

Code	End termination
K	Plated
J	Soft Termination
S	Cu Internal Electrodes
R	High Reliability Application

④ Dimension (L × W)

Type	Dimensions (L × W) [mm]	EIA (inch)
063	0.6 × 0.3	0201
105	1.0 × 0.5	0402
	0.52 × 1.0 ※	0204
107	1.6 × 0.8	0603
	0.8 × 1.6 ※	0306
212	2.0 × 1.25	0805
	1.25 × 2.0 ※	0508
316	3.2 × 1.6	1206
325	3.2 × 2.5	1210
432	4.5 × 3.2	1812

Note: ※ LW reverse type (□WK) only

⑤ Dimension tolerance

Code	Type	L [mm]	W [mm]	T [mm]
△	ALL	Standard	Standard	Standard
A	063	0.6 ± 0.05	0.3 ± 0.05	0.3 ± 0.05
	105	1.0 ± 0.10	0.5 ± 0.10	0.5 ± 0.10
	107	1.6 + 0.15 / - 0.05	0.8 + 0.15 / - 0.05	0.8 + 0.15 / - 0.05
	212	2.0 + 0.15 / - 0.05	1.25 + 0.15 / - 0.05	0.85 ± 0.10
				1.25 + 0.15 / - 0.05
	316	3.2 ± 0.20	1.6 ± 0.20	1.6 ± 0.20
B	325	3.2 ± 0.30	2.5 ± 0.30	2.5 ± 0.30
	105	1.0 + 0.15 / - 0.05	0.5 + 0.15 / - 0.05	0.5 + 0.15 / - 0.05
	107	1.6 + 0.20 / - 0	0.8 + 0.20 / - 0	0.8 + 0.20 / - 0
	212	2.0 + 0.20 / - 0	1.25 + 0.20 / - 0	0.85 ± 0.10
				1.25 + 0.20 / - 0
	316	3.2 ± 0.30	1.6 ± 0.30	1.6 ± 0.30
C	105	1.0 + 0.20 / - 0	0.5 + 0.20 / - 0	0.5 + 0.20 / - 0
	107	1.6 + 0.25 / - 0	0.8 + 0.25 / - 0	0.8 + 0.25 / - 0
	212	2.0 + 0.25 / - 0	1.25 + 0.25 / - 0	1.25 + 0.25 / - 0
K	212	2.0 ± 0.15	1.25 ± 0.15	0.85 ± 0.15
	316	3.2 ± 0.20	1.6 ± 0.20	1.15 ± 0.20
				1.6 ± 0.20
	325	3.2 ± 0.50	2.5 ± 0.30	2.5 ± 0.30

Note: P.22 Standard external dimensions

△ = Blank space

⑥ Temperature characteristics code

■ High dielectric type

Code	Applicable standard	Temperature range [°C]	Ref. Temp. [°C]	Capacitance change	Capacitance tolerance	Tolerance code
BJ	EIA	X5R	-55 ~ + 85	± 15%	± 10%	K
					± 20%	M
B7	EIA	X7R	-55 ~ + 125	± 15%	± 10%	K
					± 20%	M
C6	EIA	X6S	-55 ~ + 105	± 22%	± 10%	K
					± 20%	M
C7	EIA	X7S	-55 ~ + 125	± 22%	± 10%	K
					± 20%	M
D7	EIA	X7T	-55 ~ + 125	+ 22% / - 33%	± 10%	K
					± 20%	M

■ Temperature compensating type

■ Temperature compensating type							
Code	Applicable standard		Temperature range [°C]	Ref. Temp. [°C]	Capacitance change	Capacitance tolerance	Tolerance code
CG	JIS	CG	−55~+125	20	0±30ppm/°C	±0.1pF	B
						±0.25pF	C
						±0.5pF	D
	EIA	C0G		25		±1pF	F
						±2%	G
						±5%	J

⑦ Nominal capacitance

Code (example)	Nominal capacitance
0R5	0.5 pF
010	1 pF
100	10 pF
101	100 pF
102	1,000 pF
103	0.01 μF
104	0.1 μF
105	1.0 μF
106	10 μF
107	100 μF

Note : R=Decimal point

⑧ Capacitance tolerance

Code	Capacitance tolerance
B	± 0.1 pF
C	± 0.25 pF
D	± 0.5 pF
G	± 2%
J	± 5%
K	± 10%
M	± 20%

⑨ Thickness

Code	Thickness [mm]
P	0.3
T	
V	0.5
C	0.7 (107 type or more)
A	0.8
D	0.85 (212 type or more)
F	1.15
G	1.25
H	1.5
L	1.6
N	1.9
M	2.5

⑩ Special code

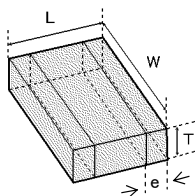
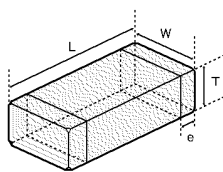
Code	Special code
H	MLCC for Industrial and Automotive

⑪ Packaging

Code	Packaging
F	φ 178mm Taping (2mm pitch)
R	φ 178mm Embossed Taping (4mm pitch)
T	φ 178mm Taping (4mm pitch)
P	φ 178mm Taping (4mm pitch, 1000 pcs/reel) 325 type (Thickness code M)

⑫ Internal code

Code	Internal code
△	Standard



※ LW reverse type

Type(EIA)	Dimension [mm] (inch)				
	L	W	T	*1	e
□MK063 (0201)	0.6±0.03 (0.024±0.001)	0.3±0.03 (0.012±0.001)	0.3±0.03 (0.012±0.001)	T	0.15±0.05 (0.006±0.002)
□MK105 (0402)	1.0±0.05 (0.039±0.002)	0.5±0.05 (0.020±0.002)	0.5±0.05 (0.020±0.002)	V	0.25±0.10 (0.010±0.004)
□WK105 (0204) ※	0.52±0.05 (0.020±0.002)	1.0±0.05 (0.039±0.002)	0.3±0.05 (0.012±0.002)	P	0.18±0.08 (0.007±0.003)
□MK107 (0603)	1.6±0.10 (0.063±0.004)	0.8±0.10 (0.031±0.004)	0.8±0.10 (0.031±0.004)	A	0.35±0.25 (0.014±0.010)
□MJ107 (0603)	1.6±0.10 (0.063±0.004)	0.8±0.10 (0.031±0.004)	0.8±0.10 (0.031±0.004)	A	0.35±0.25 (0.014±0.010)
□VS107 (0603)	1.6±0.10 (0.063±0.004)	0.8±0.10 (0.031±0.004)	0.7±0.10 (0.031±0.004)	C	0.35±0.25 (0.014±0.010)
□MR107 (0603)	1.6±0.10 (0.063±0.004)	0.8±0.10 (0.031±0.004)	0.8±0.10 (0.031±0.004)	A	0.1~0.6 (0.004~0.024)
□WK107 (0306) ※	0.8±0.10 (0.031±0.004)	1.6±0.10 (0.063±0.004)	0.5±0.05 (0.020±0.002)	V	0.25±0.15 (0.010±0.006)
□MK212 (0805)	2.0±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.85±0.10 (0.033±0.004)	D	0.5±0.25 (0.020±0.010)
			1.25±0.10 (0.049±0.004)	G	
□MJ212 (0805)	2.0±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.85±0.10 (0.033±0.004)	D	0.5±0.25 (0.020±0.010)
			1.25±0.10 (0.049±0.004)	G	
□VS212 (0805)	2.0±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.85±0.10 (0.033±0.004)	D	0.5±0.25 (0.020±0.010)
□MR212 (0805)	2.0±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	1.25±0.10 (0.049±0.004)	G	0.25~0.75 (0.010~0.029)
□WK212 (0508) ※	1.25±0.15 (0.049±0.006)	2.0±0.15 (0.079±0.006)	0.85±0.10 (0.033±0.004)	D	0.3±0.2 (0.012±0.008)
□MK316 (1206)	3.2±0.15 (0.126±0.006)	1.6±0.15 (0.063±0.006)	1.15±0.10 (0.045±0.004)	F	0.5+0.35/-0.25 (0.020+0.014/-0.010)
			1.6±0.20 (0.063±0.008)	L	
□MJ316 (1206)	3.2±0.15 (0.126±0.006)	1.6±0.15 (0.063±0.006)	1.15±0.10 (0.045±0.004)	F	0.5+0.35/-0.25 (0.020+0.014/-0.010)
			1.6±0.20 (0.063±0.008)	L	
□MR316 (1206)	3.2±0.15 (0.126±0.006)	1.6±0.15 (0.063±0.006)	1.6±0.20 (0.063±0.008)	L	0.25~0.85 (0.010~0.033)
□MK325 (1210)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	1.15±0.10 (0.045±0.004)	F	0.6±0.3 (0.024±0.012)
			1.5±0.10 (0.059±0.004)	H	
			1.9±0.20 (0.075±0.008)	N	
			2.5±0.20 (0.098±0.008)	M	
□MJ325 (1210)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	1.9±0.20 (0.075±0.008)	N	0.6±0.3 (0.024±0.012)
			2.5±0.20 (0.098±0.008)	M	
□MR325 (1210)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	1.9±0.20 (0.075±0.008)	N	0.3~0.9 (0.012~0.035)
			2.5±0.20 (0.098±0.008)	M	
□MK432 (1812)	4.5±0.40 (0.177±0.016)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	M	0.9±0.6 (0.035±0.024)

Note : ※. LW reverse type, *1.Thickness code

■ STANDARD QUANTITY

Type	EIA (inch)	Dimension		Standard quantity [pcs]	
		[mm]	Code	Paper tape	Embossed tape
063	0201	0.3	T	15000	—
105	0402	0.5	V	10000	—
	0204 ※	0.30	P		
107	0603	0.7	C	4000	—
		0.8	A		
		0.8	A	—	4000
		0.8	A	3000 (Soft Termination)	—
	0306 ※	0.50	V	—	4000
212	0805	0.85	D	4000	—
		1.25	G	—	3000
		1.25	G	—	2000 (Soft Termination)
	0508 ※	0.85	D	4000	—
316	1206	1.15	F	—	3000
		1.6	L	—	2000
325	1210	1.15	F	—	2000
		1.5	H		
		1.9	N		
		2.5	M	—	500 (T), 1000 (P)
432	1812	2.5	M	—	500

Note : ※ LW Reverse type (□WK)

PART NUMBER

Soft Termination Multilayer Ceramic Capacitors**●107TYPE (Dimension:1.6×0.8mm JIS:1608 EIA:0603)**

[Temperature Characteristic B7 : X7R] 0.8mm thickness (A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness ^{*3} [mm]	Note
							Rated voltage x %		
TMJ107BB7473□AHT		25	X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
TMJ107BB7104□AHT			X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
TMJ107BB7224□AHT			X7R	0.22 μ	±10, ±20	10	150	0.8±0.2/-0	*1 *2
TMJ107BB7474□AHT			X7R	0.47 μ	±10, ±20	10	150	0.8±0.2/-0	*1 *2
TMJ107CB7105□AHR			X7R	1 μ	±10, ±20	10	150	0.8±0.25/-0	*1 *2
GMJ107BB7473□AHT		35	X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
GMJ107BB7104□AHT			X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
GMJ107BB7224□AHT			X7R	0.22 μ	±10, ±20	10	150	0.8±0.2/-0	*1 *2
GMJ107BB7474□AHT			X7R	0.47 μ	±10, ±20	10	150	0.8±0.2/-0	*1 *2
GMJ107CB7105□AHR			X7R	1 μ	±10, ±20	10	150	0.8±0.25/-0	*1 *2
UMJ107AB7102□AHT		50	X7R	1000 p	±10, ±20	3.5	200	0.8±0.15/-0.05	*1 *2
UMJ107AB7222□AHT			X7R	2200 p	±10, ±20	3.5	200	0.8±0.15/-0.05	*1 *2
UMJ107BB7472□AHT			X7R	4700 p	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
UMJ107BB7103□AHT			X7R	0.01 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
UMJ107BB7223□AHT			X7R	0.022 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
UMJ107BB7473□AHT		100	X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
UMJ107BB7104□AHT			X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
HMJ107AB7102□AHT			X7R	1000 p	±10, ±20	3.5	200	0.8±0.15/-0.05	*1 *2
HMJ107AB7222□AHT			X7R	2200 p	±10, ±20	3.5	200	0.8±0.15/-0.05	*1 *2
HMJ107BB7472□AHT			X7R	4700 p	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
HMJ107BB7103□AHT			X7R	0.01 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
HMJ107BB7223□AHT			X7R	0.022 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
HMJ107BB7473□AHT			X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2
HMJ107BB7104□AHT			X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.2/-0	*1 *2

●212TYPE (Dimension:2.0×1.25mm JIS:2012 EIA:0805)

[Temperature Characteristic B7 : X7R] 0.85mm thickness (D), 1.25mm thickness (G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness ^{*3} [mm]	Note
							Rated voltage x %		
JMJ212CB7106□GHT		6.3	X7R	10 μ	±10, ±20	10	150	1.25±0.25/-0	*1 *2
EMJ212CB7225□GHT		16	X7R	2.2 μ	±10, ±20	10	150	1.25±0.25/-0	*1 *2
EMJ212CB7475□GHT			X7R	4.7 μ	±10, ±20	10	150	1.25±0.25/-0	*1 *2
TMJ212CB7225□GHT		25	X7R	2.2 μ	±10, ±20	10	150	1.25±0.25/-0	*1 *2
GMJ212CB7105□GHT		35	X7R	1 μ	±10, ±20	10	150	1.25±0.25/-0	*1 *2
UMJ212BB7103□GHT		50	X7R	0.01 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
UMJ212BB7223□GHT			X7R	0.022 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
UMJ212BB7473□GHT			X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
UMJ212CB7105□GHT			X7R	1 μ	±10, ±20	10	150	1.25±0.25/-0	*1 *2
HMJ212KB7102□DHT		100	X7R	1000 p	±10, ±20	3.5	200	0.85±0.15	*1 *2
HMJ212KB7222□DHT			X7R	2200 p	±10, ±20	3.5	200	0.85±0.15	*1 *2
HMJ212BB7472□GHT			X7R	4700 p	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
HMJ212BB7103□GHT			X7R	0.01 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
HMJ212BB7223□GHT			X7R	0.022 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
HMJ212BB7473□GHT			X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
HMJ212BB7104□GHT			X7R	0.1 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
HMJ212BB7224□GHT			X7R	0.22 μ	±10, ±20	3.5	200	1.25±0.20/-0	*1 *2
QMJ212KB7102□DHT		250	X7R	1000 p	±10, ±20	2.5	150	0.85±0.15	*1 *2
QMJ212KB7222□DHT			X7R	2200 p	±10, ±20	2.5	150	0.85±0.15	*1 *2
QMJ212BB7472□GHT			X7R	4700 p	±10, ±20	2.5	150	1.25±0.20/-0	*1 *2
QMJ212BB7103□GHT			X7R	0.01 μ	±10, ±20	2.5	150	1.25±0.20/-0	*1 *2
QMJ212BB7223□GHT			X7R	0.022 μ	±10, ±20	2.5	150	1.25±0.20/-0	*1 *2

●316TYPE (Dimension:3.2×1.6mm JIS:3216 EIA:1206)

[Temperature Characteristic B7 : X7R] 1.15mm thickness (F), 1.6mm thickness (L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness ^{*3} [mm]	Note
							Rated voltage x %		
LMJ316BB7226□LHT		10	X7R	22 μ	±10, ±20	10	150	1.6±0.30	*1 *2
EMJ316BB7475□LHT		16	X7R	4.7 μ	±10, ±20	10	150	1.6±0.30	*1 *2
EMJ316BB7106□LHT			X7R	10 μ	±10, ±20	10	150	1.6±0.30	*1 *2
TMJ316BB7474□LHT		25	X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
TMJ316BB7475□LHT			X7R	4.7 μ	±10, ±20	10	150	1.6±0.30	*1 *2
TMJ316BB7106□LHT			X7R	10 μ	±10, ±20	10	150	1.6±0.30	*1 *2
GMJ316BB7474□LHT		35	X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
GMJ316AB7225□LHT			X7R	2.2 μ	±10, ±20	10	150	1.6±0.20	*1 *2
GMJ316BB7475□LHT			X7R	4.7 μ	±10, ±20	10	150	1.6±0.30	*1 *2
GMJ316BB7106□LHT			X7R	10 μ	±10, ±20	10	150	1.6±0.30	*1 *2
UMJ316BB7473□LHT		50	X7R	0.047 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
UMJ316BB7104□LHT			X7R	0.1 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
UMJ316BB7224□LHT			X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
UMJ316BB7474□LHT			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
UMJ316BB7105□LHT		100	X7R	1 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
UMJ316AB7225□LHT			X7R	2.2 μ	±10, ±20	10	150	1.6±0.20	*1 *2
HMJ316 B7102□FHT			X7R	1000 p	±10, ±20	3.5	200	1.15±0.10	*1 *2
HMJ316 B7222□FHT			X7R	2200 p	±10, ±20	3.5	200	1.15±0.10	*1 *2
HMJ316 B7472□FHT			X7R	4700 p	±10, ±20	3.5	200	1.15±0.10	*1 *2
HMJ316KB7103□FHT			X7R	0.01 μ	±10, ±20	3.5	200	1.15±0.20	*1 *2
HMJ316BB7223□LHT			X7R	0.022 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
HMJ316BB7473□LHT			X7R	0.047 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
HMJ316BB7104□LHT			X7R	0.1 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
HMJ316BB7224□LHT			X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
HMJ316BB7474□LHT			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2
HMJ316BB7105□LHT			X7R	1 μ	±10, ±20	3.5	200	1.6±0.30	*1 *2

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PART NUMBER

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*3 [mm]	Note
							Rated voltage x %		
QM316 B7102[FHT]		250	X7R	1000 p	±10, ±20	2.5	150	1.15±0.10	*1.*2
QM316 B7222[FHT]			X7R	2200 p	±10, ±20	2.5	150	1.15±0.10	*1.*2
QM316 B7472[FHT]			X7R	4700 p	±10, ±20	2.5	150	1.15±0.10	*1.*2
QM316KB7103[FHT]			X7R	0.01 μ	±10, ±20	2.5	150	1.15±0.20	*1.*2
QM316BB7223[LHT]			X7R	0.022 μ	±10, ±20	2.5	150	1.6±0.30	*1.*2
QM316BB7473[LHT]			X7R	0.047 μ	±10, ±20	2.5	150	1.6±0.30	*1.*2
QM316BB7104[LHT]			X7R	0.1 μ	±10, ±20	2.5	150	1.6±0.30	*1.*2
SMJ316 B7102[FHT]			X7R	1000 p	±10, ±20	2.5	120	1.15±0.10	*1.*2
SMJ316 B7222[FHT]		630	X7R	2200 p	±10, ±20	2.5	120	1.15±0.10	*1.*2
SMJ316 B7472[FHT]			X7R	4700 p	±10, ±20	2.5	120	1.15±0.10	*1.*2
SMJ316KB7103[FHT]			X7R	0.01 μ	±10, ±20	2.5	120	1.15±0.20	*1.*2
SMJ316BB7223[LHT]			X7R	0.022 μ	±10, ±20	2.5	120	1.6±0.30	*1.*2
			X7R						

● 325TYPE (Dimension:3.2×2.5mm JIS:3225 EIA:1210)

[Temperature Characteristic B7 : X7R] 1.9mm thickness (N), 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*3 [mm]	Note
							Rated voltage x %		
JMJ325KB7476[MHP]	JMJ325KB7476[MHT]	6.3	X7R	47 μ	±10, ±20	10	150	2.5±0.30	*1.*2
EMJ325KB7226[MHP]	EMJ325KB7226[MHT]	16	X7R	22 μ	±10, ±20	10	150	2.5±0.30	*1.*2
TMJ325AB7475[MHP]	TMJ325AB7475[MHT]	25	X7R	4.7 μ	±10, ±20	5	150	2.5±0.30	*1.*2
TMJ325KB7106[MHP]	TMJ325KB7106[MHT]		X7R	10 μ	±10, ±20	10	150	2.5±0.30	*1.*2
GMJ325AB7475[MHP]	GMJ325AB7475[MHT]		X7R	4.7 μ	±10, ±20	5	150	2.5±0.30	*1.*2
GMJ325KB7106[MHP]	GMJ325KB7106[MHT]	35	X7R	10 μ	±10, ±20	10	150	2.5±0.30	*1.*2
UMJ325AB7225[MHP]	UMJ325AB7225[MHT]		X7R	2.2 μ	±10, ±20	3.5	200	2.5±0.30	*1.*2
UMJ325AB7475[MHP]	UMJ325AB7475[MHT]		X7R	4.7 μ	±10, ±20	5	150	2.5±0.30	*1.*2
UMJ325KB7106[MHP]	UMJ325KB7106[MHT]	100	X7R	10 μ	±10, ±20	10	150	2.5±0.30	*1.*2
HMJ325 B7223[NHT]			X7R	0.022 μ	±10, ±20	3.5	200	1.9±0.20	*1.*2
HMJ325 B7473[NHT]			X7R	0.047 μ	±10, ±20	3.5	200	1.9±0.20	*1.*2
HMJ325 B7104[NHT]			X7R	0.1 μ	±10, ±20	3.5	200	1.9±0.20	*1.*2
HMJ325 B7224[NHT]			X7R	0.22 μ	±10, ±20	3.5	200	1.9±0.20	*1.*2
HMJ325 B7474[NHT]			X7R	0.47 μ	±10, ±20	3.5	200	1.9±0.20	*1.*2
HMJ325 B7105[NHT]			X7R	1 μ	±10, ±20	3.5	200	1.9±0.20	*1.*2
HMJ325AB7225[MHP]	HMJ325AB7225[MHT]		X7R	2.2 μ	±10, ±20	3.5	200	2.5±0.30	*1.*2
QM325 B7223[NHT]		250	X7R	0.022 μ	±10, ±20	2.5	150	1.9±0.20	*1.*2
QM325 B7473[NHT]			X7R	0.047 μ	±10, ±20	2.5	150	1.9±0.20	*1.*2
QM325 B7104[NHT]			X7R	0.1 μ	±10, ±20	2.5	150	1.9±0.20	*1.*2
QM325 B7224[NHT]			X7R	0.22 μ	±10, ±20	2.5	150	1.9±0.20	*1.*2
SMJ325 B7223[NHT]		630	X7R	0.022 μ	±10, ±20	2.5	120	1.9±0.20	*1.*2
SMJ325 B7473[NHT]			X7R	0.047 μ	±10, ±20	2.5	120	1.9±0.20	*1.*2

LW Reversal Decoupling Capacitors (LWDC™)

● 105TYPE (Dimension:0.52×1.0mm JIS:0510 EIA:0204)

[Temperature Characteristic BJ : X5R] 0.3mm thickness (P)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*3 [mm]	Note
							Rated voltage x %		
TWK105 BJ104MPHF		25	X5R	0.1 μ	±20	5	150	0.3±0.05	*1.*2
EWK105 BJ224MPHF		16	X5R	0.22 μ	±20	10	150	0.3±0.05	*1.*2
LWK105 BJ474MPHF		10	X5R	0.47 μ	±20	10	150	0.3±0.05	*1.*2
AWK105 BJ105MPHF		4	X5R	1 μ	±20	10	150	0.3±0.05	*1.*2

[Temperature Characteristic C6 : X6S, C7 : X7S] 0.3mm thickness (P)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*3 [mm]	Note
							Rated voltage x %		
EWK105 C6104MPHF		16	X6S	0.1 μ	±20	5	150	0.3±0.05	*1.*2
LWK105 C7104MPHF		10	X7S	0.1 μ	±20	5	150	0.3±0.05	*1.*2
LWK105 C6224MPHF			X6S	0.22 μ	±20	10	150	0.3±0.05	*1.*2
JWK105 C7104MPHF			X7S	0.1 μ	±20	5	150	0.3±0.05	*1.*2
JWK105 C7224MPHF		6.3	X7S	0.22 μ	±20	10	150	0.3±0.05	*1.*2
JWK105 C6474MPHF			X6S	0.47 μ	±20	10	150	0.3±0.05	*1.*2
AWK105 C7224MPHF			X7S	0.22 μ	±20	10	150	0.3±0.05	*1.*2
AWK105 C6474MPHF		4	X6S	0.47 μ	±20	10	150	0.3±0.05	*1.*2

● 107TYPE (Dimension:0.8×1.6mm JIS:0816 EIA:0306)

[Temperature Characteristic BJ : X5R] 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*3 [mm]	Note
							Rated voltage x %		
LWK107 BJ105MVHT		10	X5R	1 μ	±20	10	150	0.5±0.05	*1.*2
JWK107 BJ225MVHT		6.3	X5R	2.2 μ	±20	10	150	0.5±0.05	*1.*2
JWK107 BJ475MVHT			X5R	4.7 μ	±20	10	150	0.5±0.05	*1.*2

[Temperature Characteristic B7 : X7R, C6 : X6S, C7 : X7S] 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*3 [mm]	Note
							Rated voltage x %		
TWK107 B7104MVHT		25	X7R	0.1 μ	±20	5	150	0.5±0.05	*1.*2
EWK107 B7224MVHT		16	X7R	0.22 μ	±20	5	150	0.5±0.05	*1.*2
EWK107 B7474MVHT			X7R	0.47 μ	±20	5	150	0.5±0.05	*1.*2
LWK107 B7474MVHT			X7R	0.47 μ	±20	5	150	0.5±0.05	*1.*2
JWK107 C7105MVHT		10	X7S	1 μ	±20	10	150	0.5±0.05	*1.*2
AWK107 C6225MVHT		4	X6S	2.2 μ	±20	10	150	0.5±0.05	*1.*2
AWK107 C6475MVHT			X6S	4.7 μ	±20	10	150	0.5±0.05	*1.*2

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Multilayer Ceramic Capacitors

PACKAGING

① Minimum Quantity

Taped package

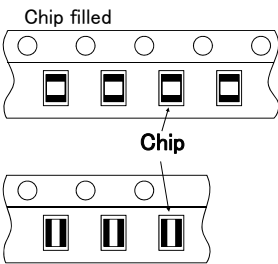
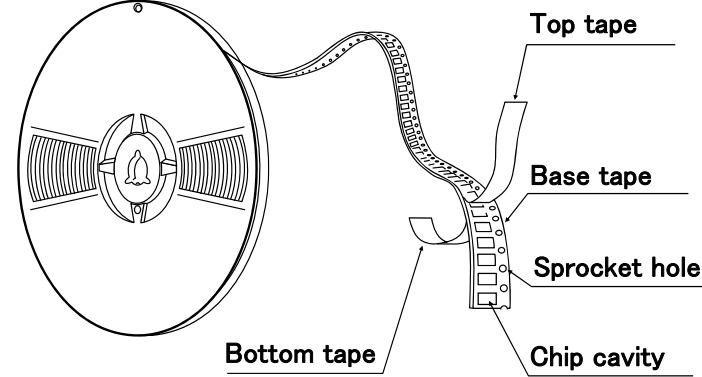
Type(EIA)	Thickness		Standard quantity [pcs]		
	mm	code	Paper tape	Embossed tape	
□MK021(008004)	0.125	K	—	50000	
□MK042(01005)	0.2	C, D	—	40000	
□VS042(01005)	0.2	C			
□MK063(0201)	0.3	P, T	15000	—	
□WK105(0204) ※	0.3	P	10000		
□MK105(0402)	0.13	H	—	20000	
	0.18	E	—	15000	
	0.2	C	20000	—	
	0.3	P	15000		
	0.5	V	10000		
□VK105(0402) ※	0.5	W			
□MK107(0603)	0.45	K	4000		4000
□WK107(0306) ※	0.5	V	—		
□MR107(0603)	0.8	A	4000		
□MK212(0805)	0.45	K		—	3000
□WK212(0508) ※	0.85	D			
□MR212(0805)	125	G			
□MK316(1206) □MR316(1206)	0.85	D	4000	—	
	1.15	F	—	3000	
	125	G			
		1.6	L	—	2000
□MK325(1210) □MR325(1210)	0.85	D	—	2000	
	1.15	F			
	1.9	N			
	2.0max.	Y			
		2.5	M	—	1000
□MK432(1812)	2.5	M	—	500	

Note : ※ LW Reverse type.

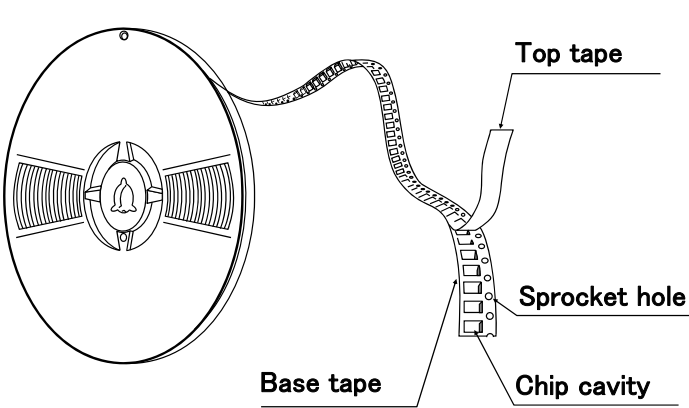
② Taping material

※No bottom tape for pressed carrier tape

Card board carrier tape



Embossed tape

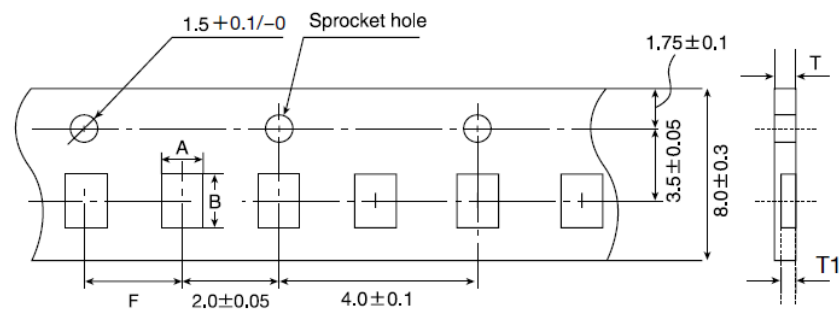


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③ Representative taping dimensions

● Paper Tape (8mm wide)

● Pressed carrier tape (2mm pitch)



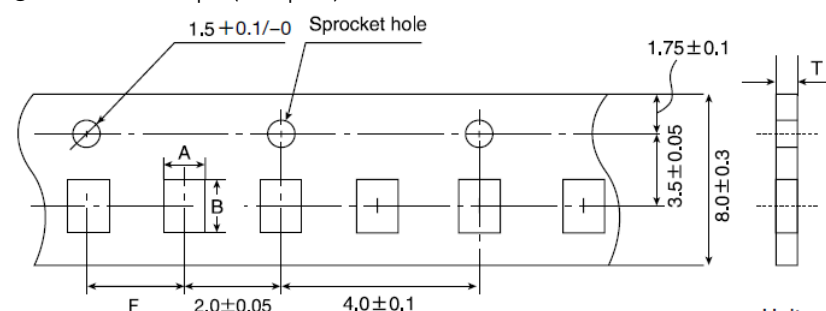
Unit : mm

Type(EIA)	Chip Cavity		Unit: mm	Insertion Pitch		Tape Thickness	
	A	B		F	T	T1	
□MK063(0201)	0.37	0.67		2.0±0.05	0.45max.	0.42max.	
□WK105(0204) ※	0.65	1.15			0.4max.	0.3max.	
□MK105(0402) (*1 C)					0.45max.	0.42max.	
□MK105(0402) (*1 P)							

Note *1 Thickness, C: 0.2mm ,P: 0.3mm. ※ LW Reverse type.

Unit : mm

● Punched carrier tape (2mm pitch)

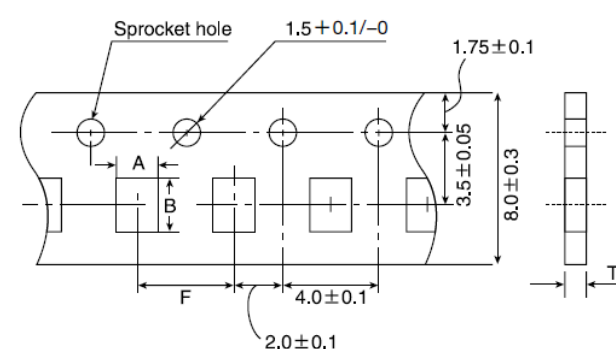


Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness
	A	B	F	T
□MK105 (0402)	0.65	1.15	2.0 ± 0.05	0.8max.
□VK105 (0402)				

Unit : mm

● Punched carrier tape (4mm pitch)



Unit : mm

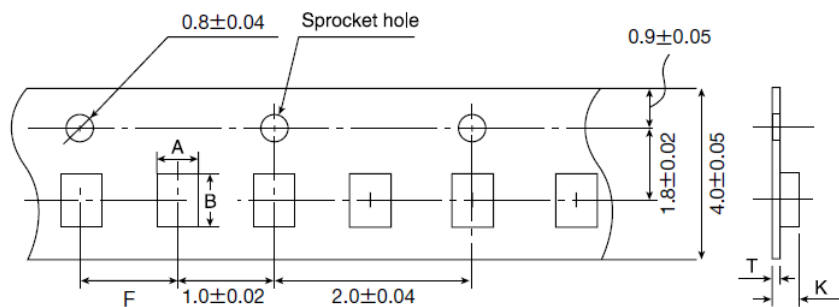
Unit: mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	T	
□MK107(0603) □WK107(0306) ※ □MR107(0603)	1.0	1.8	4.0±0.1	1.1max.	
□MK212(0805) □WK212(0508) ※					2.4
□MK316(1206)					
	1.65			1.1max.	
	2.0				

Note : Taping size might be different depending on the size of the product. ※ LW Reverse type.

Unit : mm

● Embossed tape (4mm wide)

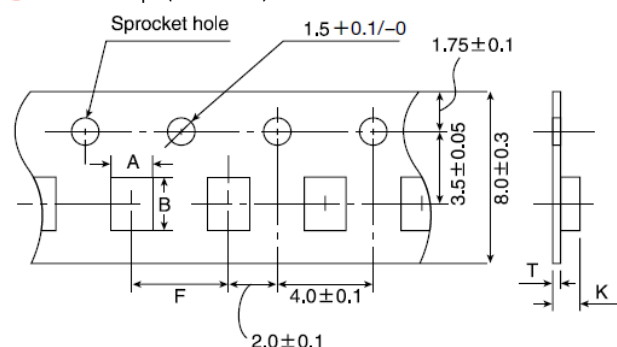


Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
□MK021(008004)	0.135	0.27	1.0±0.02	0.5max.	0.25max.
□MK042(01005)	0.23	0.43			
□VS042(01005)					

Unit : mm

● Embossed tape (8mm wide)



Unit : mm

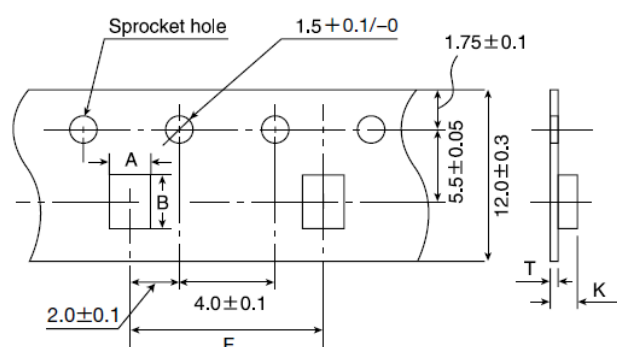
Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B		F	K
□MK105(0402)	0.6	1.1	2.0±0.1	0.6max	0.2±0.1
□WK107(0306) ※	1.0	1.8	4.0±0.1	1.3max.	0.25±0.1
□MK212(0805)	1.65	2.4		3.4max.	0.6max.
□MR212(0805)					
□MK316(1206)	2.0	3.6			
□MR316(1206)					
□MK325(1210)	2.8	3.6			
□MR325(1210)					

Note: ※ LW Reverse type.

Unit : mm

● Embossed tape (12mm wide)

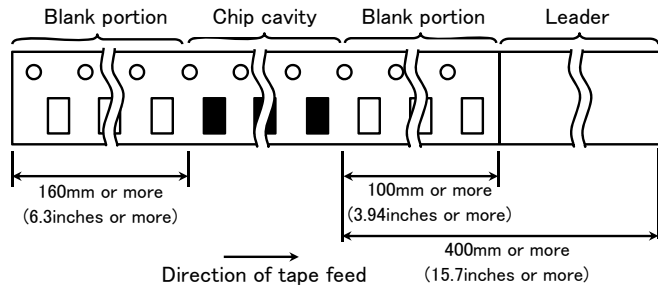


Unit : mm

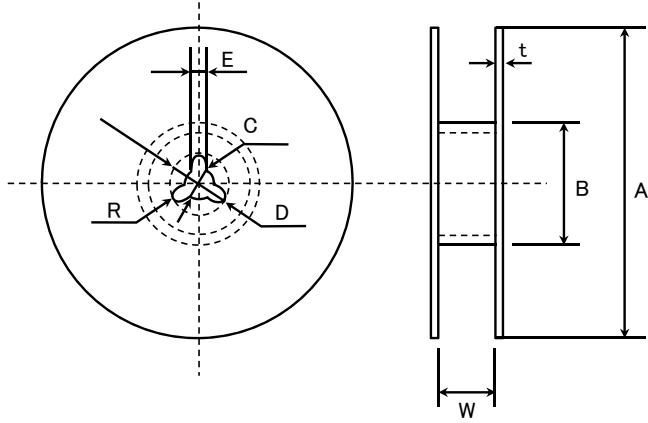
Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B		K	T
□MK432(1812)	3.7	4.9	8.0±0.1	4.0max.	0.6max.

Unit : mm

④Trailer and Leader



⑤Reel size



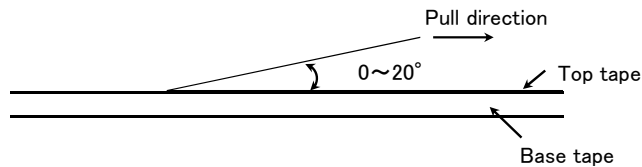
A	B	C	D	E	R
$\phi 178 \pm 2.0$	$\phi 50 \text{ min.}$	$\phi 13.0 \pm 0.2$	$\phi 21.0 \pm 0.8$	2.0 ± 0.5	1.0

	T	W
4mm wide tape	1.5max.	5 ± 1.0
8mm wide tape	2.5max.	10 ± 1.5
12mm wide tape	2.5max.	14 ± 1.5

Unit: mm

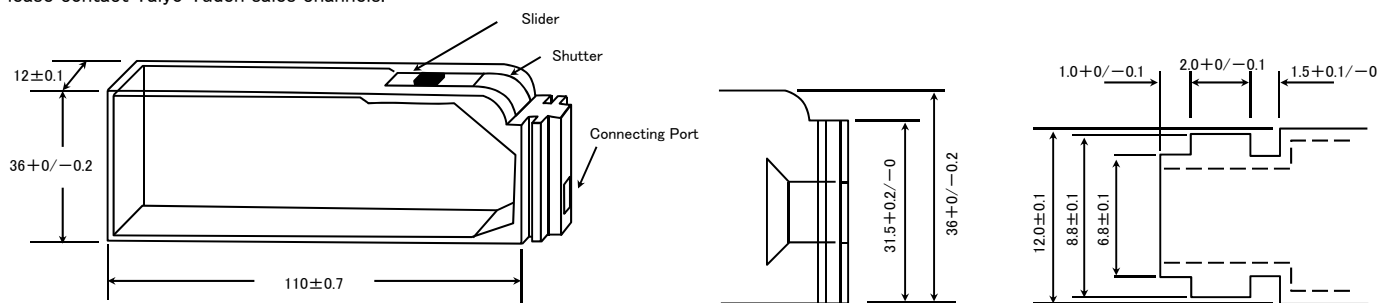
⑥Top Tape Strength

The top tape requires a peel-off force of 0.1 to 0.7N in the direction of the arrow as illustrated below.



⑦Bulk Cassette

The exchange of individual specification is necessary.
Please contact Taiyo Yuden sales channels.



Unit: mm

Multilayer Ceramic Capacitors

RELIABILITY DATA

1. Operating Temperature Range

Specified Value	Temperature Compensating (Class1)	Standard	−55 to +125℃																							
		High Frequency Type																								
	High Permittivity (Class2)	<table><tr><td></td><td>Specification</td><td>Temperature Range</td></tr><tr><td rowspan="2">BJ</td><td>B</td><td>−25 to +85℃</td></tr><tr><td>X5R</td><td>−55 to +85℃</td></tr><tr><td>B7</td><td>X7R</td><td>−55 to +125℃</td></tr><tr><td>C6</td><td>X6S</td><td>−55 to +105℃</td></tr><tr><td>C7</td><td>X7S</td><td>−55 to +125℃</td></tr><tr><td>D7</td><td>X7T</td><td>−55 to +125℃</td></tr><tr><td>LD(※)</td><td>X5R</td><td>−55 to +85℃</td></tr></table> Note: ※LD Low distortion high value multilayer ceramic capacitor				Specification	Temperature Range	BJ	B	−25 to +85℃	X5R	−55 to +85℃	B7	X7R	−55 to +125℃	C6	X6S	−55 to +105℃	C7	X7S	−55 to +125℃	D7	X7T	−55 to +125℃	LD(※)	X5R
	Specification	Temperature Range																								
BJ	B	−25 to +85℃																								
	X5R	−55 to +85℃																								
B7	X7R	−55 to +125℃																								
C6	X6S	−55 to +105℃																								
C7	X7S	−55 to +125℃																								
D7	X7T	−55 to +125℃																								
LD(※)	X5R	−55 to +85℃																								

2. Storage Conditions

Specified Value	Temperature Compensating(Class1)	Standard	−55 to +125℃			
		High Frequency Type				
	High Permittivity (Class2)					
		BJ	Specification	Temperature Range		
			B	−25 to +85℃		
		X5R	−55 to +85℃			
		B7	X7R	−55 to +125℃		
		C6	X6S	−55 to +105℃		
		C7	X7S	−55 to +125℃		
		D7	X7T	−55 to +125℃		
LD(※)	X5R	−55 to +85℃				
Note: ※LD Low distortion high value multilayer ceramic capacitor						

3. Rated Voltage

Specified Value	Temperature Compensating (Class1)	Standard	50VDC, 25VDC
		High Frequency Type	50VDC, 25VDC
	High Permittivity (Class2)		50VDC, 35VDC, 25VDC, 16VDC, 10VDC, 6.3VDC, 4VDC, 2.5VDC

4. Withstanding Voltage (Between terminals)

Specified Value	Temperature Compensating (Class1)	Standard	No breakdown or damage
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Class 1	Class 2
	Applied voltage	Rated volta × 3	Rated voltage × 2.5
	Duration	1 to 5 sec.	
	Charge/discharge current	50mA max.	

5. Insulation Resistance

Specified Value	Temperature Compensating (Class1)	Standard	10000 MΩ min.
		High Frequency Type	
Specified Value	High Permittivity (Class2) Note 1		C ≤ 0.047 μF : 10000 MΩ min. C > 0.047 μF : 500MΩ · μF
Test Methods and Remarks	Applied voltage		: Rated voltage
	Duration		: 60±5 sec.
	Charge/discharge current		: 50mA max.

6. Capacitance (Tolerance)						
Specified Value	Temperature Compensating(Class1)	Standard	C□	0.2pF≤C≤5pF : ±0.25pF		
			U□	0.2pF≤C≤10pF : ±0.5pF		
			SL	C>10pF : ±5% or ±10%		
		High Frequency Type	CH	0.3pF≤C≤2pF : ±0.1pF		
	C>2pF : ±5%					
High Permittivity (Class2)			BJ, B7, C6, C7, D7, LD(※) : ±10% or ±20% Note: ※LD Low distortion high value multilayer ceramic capacitor			
Test Methods and Remarks			Class 1		Class 2	
		Standard	High Frequency Type		C≤10μF	C>10μF
	Preconditioning	None			Thermal treatment (at 150°C for 1hr) Note 2	
	Measuring frequency	1MHz±10%			1kHz±10%	120±10Hz
	Measuring voltage Note	0.5 to 5Vrms			1±0.2Vrms	0.5±0.1rms
	Bias application	one				

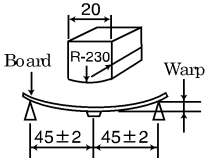
7. Q or Dissipation Factor					
Specified Value	Temperature Compensating(Class1)	Standard	C < 30pF : Q ≥ 400 + 20C C ≥ 30pF : Q ≥ 1000 (C : Nominal capacitance)		
		High Frequency Type	Refer to detailed specification		
	High Permittivity (Class2) Note 1		BJ, B7, C6, C7, D7 : 2.5% max.		
Test Methods and Remarks		Class 1		Class 2	
		Standard	High Frequency Type	C ≤ 10 μ F	C > 10 μ F
	Preconditioning	None		Thermal treatment (at 150°C for 1hr) Note 2	
	Measuring freqeuy	1MHz ± 10%	1GHz	1kHz ± 10%	120 ± 10Hz
	Measuring voltage Note 1	0.5 to 5Vrms		1 ± 0.2Vrms	0.5 ± 0.1Vrms
	Bias application	None			
	High Frequency Type				
	Measuring equipment		: HP4291A		
	Measuring jig		: HP16192A		

8. Temperature Characteristic (Without voltage application)																		
Specified Value	Temperature Compensating(Class1)	Standard	Temperature Characteristic [ppm/°C]		Tolerance [ppm/°C]													
			C□ : 0	CG,CH, CJ, CK	G : ±30	H : ±60 J : ±120 K : ±250												
			U□ : −750	UJ, UK														
			SL : +350 to −1000															
	High Frequency Type	Temperature Characteristic [ppm/°C]		Tolerance [ppm/°C]														
		C□ : 0	CH	H : ±60														
	High Permittivity (Class2)																	
			Specification	Capacitance change	Reference temperature	Temperature Range												
		BJ	B	±10%	20°C	−25 to +85°C												
			X5R	±15%	25°C	−55 to +85°C												
B7		X7R	±15%	25°C	−55 to +125°C													
C6		X6S	±22%	25°C	−55 to +105°C													
C7		X7S	±22%	25°C	−55 to +125°C													
D7		X7S	+22/−33%	25°C	−55 to +125°C													
LD(※)		X5R	±15%	25°C	−55 to +85°C													
Note : ※LD Low distortion high value multilayer ceramic capacitor																		
Test Methods and Remarks	Class 1																	
	Capacitance at 20°C and 85°C shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.																	
	$\frac{(C_{85}-C_{20})}{C_{20} \times \Delta T} \times 10^6 \text{ (ppm/}^\circ\text{C)} \qquad \Delta T=65$																	
	Class 2																	
	Capacitance at each step shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.																	
	<table><tr><td>Step</td><td>B</td><td>X5R、X7R、X6S、X7S、X7T</td></tr><tr><td>1</td><td colspan="2">Minimum operating temperature</td></tr><tr><td>2</td><td>20°C</td><td>25°C</td></tr><tr><td>3</td><td colspan="2">Maximum operating temperature</td></tr></table>						Step	B	X5R、X7R、X6S、X7S、X7T	1	Minimum operating temperature		2	20°C	25°C	3	Maximum operating temperature	
	Step	B	X5R、X7R、X6S、X7S、X7T															
	1	Minimum operating temperature																
	2	20°C	25°C															
	3	Maximum operating temperature																

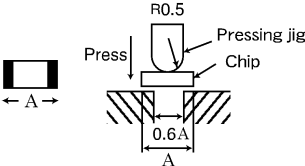
► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification.
For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.ty-top.com/>).

	$\frac{(C-C_2)}{C_2} \times 100(\%)$ C : Capacitance in Step 1 or Step 3 C2 : Capacitance in Step 2		
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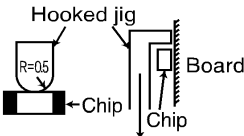
9. Deflection

Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 5\%$ or ± 0.5 pF, whichever is larger.																		
		High Frequency Type	Appearance : No abnormality Capaitance change : Within ± 0.5 pF																		
	High Permittivity (Class2)		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, D7, LD(※)) Note: ※LD Low distortion high value multilayer ceramic capacitor																		
Test Methods and Remarks	<table><tr><td></td><td colspan="2">Multilayer Ceramic Capacitors</td></tr><tr><td></td><td>042, 063, ※105 Type</td><td>The other types</td></tr><tr><td>Board</td><td colspan="2">Glass epoxy-resin substrate</td></tr><tr><td>Thickness</td><td>0.8mm</td><td>1.6mm</td></tr><tr><td>Warp</td><td colspan="2">1mm (Soft Termination type:3mm)</td></tr><tr><td>Duration</td><td colspan="2">10 sec.</td></tr></table>				Multilayer Ceramic Capacitors			042, 063, ※105 Type	The other types	Board	Glass epoxy-resin substrate		Thickness	0.8mm	1.6mm	Warp	1mm (Soft Termination type:3mm)		Duration	10 sec.	
		Multilayer Ceramic Capacitors																			
	042, 063, ※105 Type	The other types																			
Board	Glass epoxy-resin substrate																				
Thickness	0.8mm	1.6mm																			
Warp	1mm (Soft Termination type:3mm)																				
Duration	10 sec.																				
	※1: 105 Type thickness, C: 0.2mm ,P: 0.3mm.																				
	 (Unit: mm) Capacitance measurement shall be conducted with the board bent																				

10. Body Strength

Specified Value	Temperature Compensating(Class1)	Standard	—
		High Frequency Type	No mechanical damage.
	High Permittivity (Class2)		—
Test Methods and Remarks	High Frequency Type Applied force : 5N uration : 10 sec. 		

11. Adhesive Strength of Terminal Electrodes

Specified Value	Temperature Compensating(Class1)	Standard	No terminal separation or its indication.
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Multilayer Ceramic Capacitors	
		042, 063 Type	105 Type or more
	Applied force	2N	5N
	Duration	30±5 sec.	
			

12. Solderability

Specified Value	Temperature Compensating(Class1)	Standard	At least 95% of terminal electrode is covered by new solder.
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Eutectic solder	Lead-free solder
	Solder type	H60A or H63A	Sn-3.0Ag-0.5Cu
	Solder temperature	230±5℃	245±3℃
	Duration	4±1 sec.	

13. Resistance to Soldering					
Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormalty Capacitance change : Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$, whichever is larger. Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality		
		High Frequency Type	Appearance : No abnormality Capacitanceceange : Within $\pm 2.5\%$ Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality		
	High Permittivity (Class2) Note 1		Appearance : No abnormalty Capactace change : Within $\pm 7.5\%$ (BJ, B7, C6, C7, D7, LD(※)) Dissipation factor : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals): No abnormality Note: ※LD Low distortion high value multilayer ceramic capacitor		
Test Methods and Remarks		Iss 1			
		042, 063 Type		105 Type	
	Preconditioning	None			
	Preheating	150°C, 1 to 2 min.	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5 min.		
	Solder temp.	270 $\pm$ 5°C			
	Duration	3 $\pm$ 0.5 sec.			
	Recovery	6 to 24 hrs (Standard condition) Noe 5			
		Class 2			
		042, 063 Type		105, 107, 212 Type	316, 325 Type
	Preconditioning	Thermal treatment (at 150°C for 1 hr) Note 2			
	Preheating	150°C, 1 to 2 min.	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5 min.	80 to 100°C, 5 to 10 min. 150 to 200°C, 5 to 10 min.	
	Solder temp.	270 $\pm$ 5°C			
	Duration	3 $\pm$ 0.5 sec.			
	Recovery	24 $\pm$ 2 hrs (Standard condition) Note 5			

14. Temperature Cycle (Thermal Shock)																			
Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$, whichever is larger. Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality																
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 0.25\text{pF}$ Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality																
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 7.5\%$ (BJ, B7, C6, C7, D7, LD(※)) Dissipation factor : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality Note: ※LD Low distortion high value multilayer ceramic capacitor																
Test Methods and Remarks		Class 1	Class 2																
	Preconditioning	None	Thermal treatment (at 150°C for 1 hr) Note 2																
	1 cycle	<table><tr><td>Step</td><td>Temperature (°C)</td><td>Time (min.)</td></tr><tr><td>1</td><td>Minimum operating temperature</td><td>30±3</td></tr><tr><td>2</td><td>Normal temperature</td><td>2 to 3</td></tr><tr><td>3</td><td>Maximum operating temperature</td><td>30±3</td></tr><tr><td>4</td><td>Normal temperature</td><td>2 to 3</td></tr></table>			Step	Temperature (°C)	Time (min.)	1	Minimum operating temperature	30±3	2	Normal temperature	2 to 3	3	Maximum operating temperature	30±3	4	Normal temperature	2 to 3
		Step	Temperature (°C)	Time (min.)															
		1	Minimum operating temperature	30±3															
		2	Normal temperature	2 to 3															
3		Maximum operating temperature	30±3																
4	Normal temperature	2 to 3																	
Number of cycles	5 times																		
Recovery	6 to 24 hrs (Standard condition) Note 5		24±2 hrs (Standard condition) Note 5																

15. Humidity (Steady State)				
Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger. Q : $C < 10\text{pF} : Q \geq 200 + 10C$ $10 \leq C < 30\text{pF} : Q \geq 275 + 2.5C$ $C \geq 30\text{pF} : Q \geq 350 (C: \text{Nominal capacitance})$ Insulation resistance : $1000 \text{ M}\Omega \text{ min.}$	
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 0.5\text{pF}$, Insulation resistance : $1000 \text{ M}\Omega \text{ min.}$	
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, D7, LD(※)) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, D7, LD(※)) Insulation resistance : $50 \text{ M}\Omega \mu\text{F}$ or $1000 \text{ M}\Omega$ whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor	
Test Methods and Remarks		Class 1		Class 2
		Standard	High Frequency Type	All items
		Preconditioning	None	Thermal treatment (at 150°C for 1 hr) Note 2
		Temperature	$40 \pm 2^\circ\text{C}$	$40 \pm 2^\circ\text{C}$
		Humidity	90 to 95%RH	90 to 95%RH
		Duration	$500 + 24 / - 0 \text{ hrs}$	$500 + 24 / - 0 \text{ hrs}$
		Recovery	6 to 24 hrs (Standard condition) Note 5	$24 \pm 2 \text{ hrs}$ (Standard condition) Note 5

16. Humidity Loading				
Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 7.5\%$ or $\pm 0.75\text{pF}$, whichever is larger. Q : $C < 30\text{pF} : Q \geq 100 + 10C/3$ $C \geq 30\text{pF} : Q \geq 200 (C: \text{Nominal capacitance})$ Insulation resistance : $500 \text{ M}\Omega \text{ min.}$	
		High Frequency Type	Appearance : No abnormality Capacitance change : $C \leq 2\text{pF} : \text{Within } \pm 0.4 \text{ pF}$ $C > 2\text{pF} : \text{Within } \pm 0.75 \text{ pF}$ (C: Nominal capacitance) Insulation resistance : $500 \text{ M}\Omega \text{ min.}$	
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, D7, LD(※)) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, D7, LD(※)) Insulation resistance : $25 \text{ M}\Omega \mu\text{F}$ or $500 \text{ M}\Omega$, whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor	
Test Methods and Remarks		Class 1		Class 2
		Standard	High Frequency Type	All items
		Preconditioning	None	Voltage treatment (Rated voltage are applied for 1 hour at 40°C) Note 3
		Temperature	$40 \pm 2^\circ\text{C}$	$40 \pm 2^\circ\text{C}$
		Humidity	90 to 95%RH	90 to 95%RH
		Duration	$500 + 24 / - 0 \text{ hrs}$	$500 + 24 / - 0 \text{ hrs}$
		Applied voltage	Rated voltage	Rated voltage
		Charge/discharge current	50mA max.	50mA max.
		Recovery	6 to 24 hrs (Standard condition) Note 5	$24 \pm 2 \text{ hrs}$ (Standard condition) Note 5

17. High Temperature Loading						
Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 3\%$ or $\pm 0.3\text{pF}$, whichever is larger. Q : $C < 10\text{pF}$: $Q \geq 200 + 10C$ $10 \leq C < 30\text{pF}$: $Q \geq 275 + 2.5C$ $C \geq 30\text{pF}$: $Q \geq 350$ (C: Nominal capacitance) Insulation resistance : $1000 \text{ M}\Omega \text{ min.}$			
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 3\%$ or $\pm 0.3\text{pF}$, whichever is larger. Insulation resistance : $1000 \text{ M}\Omega \text{ min.}$			
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, D7, LD(※)) Dissipation factor : 5.0% max.(BJ, B7, C6, C7, D7, LD(※)) Insulation resistance : $50 \text{ M}\Omega \mu \text{F}$ or $1000 \text{ M}\Omega$, whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor			
Test Methods and Remarks		Class 1		Class 2		
		Standard	High Frequency Type	BJ, LD(※)	C6	B7, C7, D7
	Preconditioning	None		Voltage treatment (Twice the rated voltage shall be applied for 1 hour at 85°C , 105°C or 125°C) Note 3, 4		
	Temperature	Maximum operating temperature		Maximum operating temperature		
	Duration	$1000 + 48 / -0 \text{ hrs}$		$1000 + 48 / -0 \text{ hrs}$		
	Applied voltage	Rated voltage $\times 2$		Rated voltage $\times 2$ Note 4		
	Charge/discharge current	50mA max.		50mA max.		
	Recovery	6 to 24hr (Standard condition) Note 5		$24 \pm 2 \text{ hrs}$ (Standard condition) Note 5		
Note: ※LD Low distortion high value multilayer ceramic capacitor						
Note 1 The figures indicate typical specifications. Please refer to individual specifications in detail.						
Note 2 Thermal treatment : Initial value shall be measured after test sample is heat-treated at $150 + 0 / -10^{\circ}\text{C}$ for an hour and kept at room temperature for 24 ± 2 hours.						
Note 3 Voltage treatment : Initial value shall be measured after test sample is voltage-treated for an hour at both the temperature and voltage specified in the test conditions, and kept at room temperature for 24 ± 2 hours.						
Note 4 150% of rated voltage is applicable to some items. Please refer to their specifications for further information.						
Note 5 Standard condition: Temperature: 5 to 35°C , Relative humidity: 45 to 85 % RH, Air pressure: 86 to 106kPa When there are questions concerning measurement results, in order to provide correlation data, the test shall be conducted under the following condition. Temperature: $20 \pm 2^{\circ}\text{C}$, Relative humidity: 60 to 70 % RH, Air pressure: 86 to 106kPa Unless otherwise specified, all the tests are conducted under the "standard condition".						

Medium-High Voltage Multilayer Ceramic Capacitor

RELIABILITY DATA

1. Operating Temperature Range

Specified Value	Temperature Compensating(High Frequency type) CG(C0G) : -55 to +125°C
	High permittivity X7R, X7S : -55 to +125°C X5 : -55 to +85°C B : -25 to +85°C

2. Storage Temperature Range

Specified Value	Temperature Compensating(High Frequency type) CG(C0G) : -55 to +125°C
	High permittivity X7R, X7S : -55 to +125°C X5R : -55 to +85°C B : -25 to +85°C

3. Rated Voltage

Specified Value	100VDC(HMK,HMJ), 250VDC(QMK,QMJ,QVS), 630VDC(SMK,SMJ)
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4. Withstanding Voltage (Between terminals)

Specified Value	No breakdown or damage
Test Methods and Remarks	Applied voltage : Rated voltage × 2.5 (HMK,HMJ), Rated voltage × 2 (QMK,QMJ,QVS), Rated voltage × 1.2 (SMK,SMJ) Duration : 1 to 5sec. Charge/discharge current : 50mA max.

5. Insulation Resistance

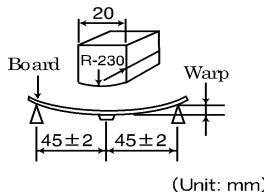
Specified Value	Temperature Compensating(High Frequency type) 10000MΩ min
	High permittivity 100MΩ μF or 10GΩ, whichever is smaller.
Test Methods and Remarks	Applied voltage : Rated voltage (HMK,HMJ, QMK,QMJ,QVS), 500V (SMK,SMJ) Duration : 60±5sec. Charge/discharge current : 50mA max.

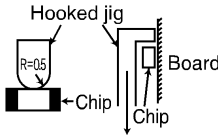
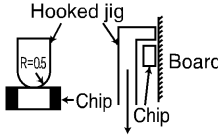
6. Capacitance (Tolerance)

Specified Value	Temperature Compensating(High Frequency type) ±0.1pF (C<5pF) ±0.25pF (C<10pF) ±0.5pF (5pF≤C<10pF) ±2%(C=10pF) ±5%(C≥10pF)
	High permittivity ±10%, ±20%
Test Methods and Remarks	Temperature Compensating(High Frequency type) Measuring frequency : 1MHz±10% Measuring voltage : 0.5 to 5Vrms Bias application : None
	High permittivity Measuring frequency : 1kHz±10% Measuring voltage : 1±0.2Vrms Bias application : None

7. Q or Dissipation Factor	
Specified Value	Temperature Compensating(High Frequency type) $C < 30\text{pF} : Q \geq 800 + 20C$ $C \geq 30\text{pF} : Q \geq 1400$ C:Normal Capacitance(/pF) High permittivity 3.5%max (HMK,HMJ) 2.5%max (QMK,QMJ, SMK,SMJ)
Test Methods and Remarks	Temperature Compensating(High Frequency type) Measuring frequency : 1MHz±10% Measuring voltage : 0.5 to 5Vrms Bas application : None High permittivity Measuring frequency : 1kHz±10% Measuring voltage : 1±0.2Vrms Bas application : None

8. Temperature Characteristic of Capacitance			
Specified Value	Temperature Compensating(High Frequency type) C0G : ±30ppm(25 to +125°C)		
	High permittivity		
	B : ±10%(−25 to +85°C)		
	X5R : ±15%(−55 to +85°C)		
	X7R : ±15%(−55 to +125°C)		
		X7S : ±22%(−55 to +125°C)	
Test Methods and Remarks	Temperature Compensating(High Frequency type)		
	Capacitance at 25°C and 85°C shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.		
	$\frac{(C_{85}-C_{25})}{C_{25} \times \Delta T} \times 10^6 \times [\text{ppm}/^{\circ}\text{C}]$		
	High permittivity		
	Capacitance value at each step shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.		
	Step	B	X5R、X7R、X7S
	1	Minimum operating tempeature	
	2	20°C	25°C
	3	Maximum operating temperature	
	$\frac{(C-C_2)}{C_2} \times 100(\%)$		
C : Capacitance value in Step 1 or Step 3			
C2 : Capacitance value in Step 2			

9. Deflection	
Specified Value	Temperature Compensating(High Frequency type) Appearance : No abnormality Capacitance change : ±5% or ±0.5pF, whichever is larger. High permittivity Appearance : No abnormality Capacitance change : Within ±10%
Test Methods and Remarks	Warp : 1mm (Soft Termination type:3mm) Duration : 10sec. Test board : Glass epoxy-resin substrate Thicknss : 1.6mm  (Unit: mm) Capacitance measurement shall be conducted with the board bent.

10. Adhesive Strength of Terminal Electrodes	
Specified Value	No terminal separation or its indication.
Test Methods and Remarks	Temperature Compensating(High Frequency type) Applied force : 2N Duration : 10±5sec.  High permittivity Applied force : 5N Duration : 30±5sec. 

11. Solderability			
Specified Value		At least 95% of terminal electrode is covered by new solder	
Test Methods and Remarks		Eutectic solder	Lead-free solder
	Solder type	H60A or H63A	Sn-3.0Ag-0.5Cu
	Solder temperature	230±5°C	245±3°C
	Duration	4±1 sec.	

12. Resistance to Soldering	
Specified Value	Temperature Compensating(High Frequency type) Appearance : No abnormality Capacitance change : C※≤10pF :±0.25pF C※>10pF :±2.5% ※Normal capacitance Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality High permittivity Appearance : No abnormality Capacitance change : Within±15%(HMK,HMJ), ±10%(QMK,QMJ, SMK,SMJ) Dissipation factor : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality
Test Methods and Remarks	Preconditioning : Thermal treatment(at 150°C for 1hr) Note1 (Only High permittivity) Solder temperature : 270±5°C Duration : 3±0.5sec. Preheating conditions : 80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5min. Recovery : 24±2hrs under the stadard condition Note3

13. Temperature Cycle (Thermal Shock)			
Specified Value	Temperature Compensating(High Frequency type)		
	Appearance : No abnormality		
	Capacitance change : C※≤10pF :±0.25% C※> 10pF :±2.5%		
	Insulation resistance : Initial value		
	Withstanding voltage (between terminals) : No abnormality		
	High permittivity		
	Appearance : No abnormality		
	Capacitance change : Within±15%(HMK,HMJ), ±7.5%(QMK,QMJ, SMK,SMJ)		
Test Methods and Remarks	Dissipation factor : Initial value		
	Insulation resistance : Initial value		
	Withstanding voltage (between terminals) : No abnormality		
	Preconditioning : Thermal treatment (at 150℃ for 1hr) Note1		
	Conditions for 1 cycle		
	Step	temperature (℃)	Time (min.)
	1	Minimum operating temperature	30±3min.
	2	Normal temperature	2 to 3min.
3	Maximum operating temperature	30±3min.	
4	Normal temperature	2 to 3min.	
Number of cycles : 5 times			
Recovery : 24±2hrs under the standard condition Note3			

14. Humidity (Steady state)	
Specified Value	Temperature Compensating(High Frequency type) Appearance : No abnormality Capacitance change : C※ ≤ 10pF : ±0.5pF C※ > 10pF : ±5% ※Normal capacitance Insulation resistance : 1000MΩ min
	High permittivity Appearance : No abnormality Capacitance change : Within ±15% Dissipation factor : 7%max (HMK,HMJ), 5%max (QMK,QMJ, SMK,SMJ). Insulation resistance : 25MΩ μ F or 1000MΩ, whichever is smaller.
Test Methods and Remarks	Preconditioning : Thermal treatment (at 150°C for 1hr) Note1 (Only High permittivity) Temperature : 40±2°C Humidity : 90 to 95%RH Duration : 500 +24/—0 hrs Recovery : 24±2hrs under the standard condition Note3
15. Humidity Loading	
Specified Value	Temperature Compensating(High Frequency type) Appearance : No abnormality Capacitance change : C※ ≤ 2.0pF : ±0.4pF 2.0pF < C ≤ 10pF : ±0.75pF C※ > 10pF : ±7.5% ※Normal capacitance Insulation resistance : 500MΩ min
	High permittivity Appearance : No abnormality Capacitance change : Within ±15% Dissipation factor : 7%max (HMK,HMJ), 5%max (QMK,QMJ, SMK,SMJ). Insulation resistance : 10MΩ μ F or 500MΩ, whichever is smaller.
Test Methods and Remarks	According to JIS 5102 clause 9.9. Preconditioning : Voltage treatment Note2 (Only High permittivity) Temperature : 40±2°C Humidity : 90 to 95%RH Applied voltage : Rated voltage Charge/discharge current : 50mA max. Duration : 500 +24/—0 hrs Recovery : 24±2hrs under the standard condition Note3
16. High Temperature Loading	
Specified Value	Temperature Compensating(High Frequency type) Appearance : No abnormality Capacitance change : C※ ≤ 10pF : ±0.3pF C※ > 10pF : ±3% Insulation resistance : 1000MΩ min
	High permittivity Appearance : No abnormality Capacitance change : Within ±15% Dissipation factor : 7%max (HMK,HMJ), 5%max (QMK,QMJ, SMK,SMJ). Insulation resistance : 50MΩ μ F or 1000MΩ, whichever is smaller.
Test Methods and Remarks	According to JIS 5102 clause 9.10. Preconditioning : Voltage treatment Note2 (Only High permittivity) Temperature : Maximum operating temperature Applied voltage : Rated voltage × 2 (HMK,HMJ,QVS) Rated voltage × 1.5 (QMK,QMJ) Rated voltage × 1.2 (SMK,SMJ) Charge/discharge current : 50mA max. Duration : 1000 +24/—0 hrs Recovery : 24±2hrs under the standard condition Note3
Note1 Thermal treatment : Initial value shall be measured after test sample is heat-treated at 150+0/—10°C for an hour and kept at room temperature for 24±2hours. Note2 Voltage treatment : Initial value shall be measured after test sample is voltage-treated for an hour at both the temperature and voltage specified in the test conditions, and kept at room temperature for 24±2hours. Note3 Standard condition : Temperature: 5 to 35°C, Relative humidity: 45 to 85 % RH, Air pressure: 86 to 106kPa When there are questions concerning measurement results, in order to provide correlation data, the test shall be conducted under the following condition. Temperature: 20±2°C, Relative humidity: 60 to 70 % RH, Air pressure: 86 to 106kPa Unless otherwise specified, all the tests are conducted under the "standard condition".	

Precautions on the use of Multilayer Ceramic Capacitors

■ PRECAUTIONS

1. Circuit Design

Precautions	◆Verification of operating environment, electrical rating and performance 1. A malfunction of equipment in fields such as medical, aerospace, nuclear control, etc. may cause serious harm to human life or have severe social ramifications. Therefore, any capacitors to be used in such equipment may require higher safety and reliability, and shall be clearly differentiated from them used in general purpose applications.
	◆Operating Voltage (Verification of Rated voltage) 1. The operating voltage for capacitors must always be their rated voltage or less. If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages shall be the rated voltage or less. For a circuit where an AC or a pulse voltage may be used, the sum of their peak voltages shall also be the rated voltage or less. 2. Even if an applied voltage is the rated voltage or less reliability of capacitors may be deteriorated in case that either a high frequency AC voltage or a pulse voltage having rapid rise time is used in a circuit.

2. PCB Design

Precautions	◆Pattern configurations (Design of Land-patterns) 1. When capacitors are mounted on PCBs, the amount of solder used (size of fillet) can directly affect the capacitor performance. Therefore, the following items must be carefully considered in the design of land patterns: (1) Excessive solder applied can cause mechanical stresses which lead to chip breaking or cracking. Therefore, please consider appropriate land-patterns for proper amount of solder. (2) When more than one component are jointly soldered onto the same land, each component's soldering point shall be separated by solder-resist.
	◆Pattern configurations (Capacitor layout on PCBs) After capacitors are mounted on boards, they can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering of the boards, etc.). For this reason, land pattern configurations and positions of capacitors shall be carefully considered to minimize stresses.

◆Pattern configurations (Design of Land-patterns)
The following diagrams and tables show some examples of recommended land patterns to prevent excessive solder amounts.

(1) Recommended land dimensions for typical chip capacitors

●Multilayer Ceramic Capacitors : Recommended land dimensions

(unit: mm)

Wave-soldering

Type		107	212	316	325
Size	L	1.6	2.0	3.2	3.2
	W	0.8	1.25	1.6	2.5
A		0.8 to 1.0	1.0 to 1.4	1.8 to 2.5	1.8 to 2.5
B		0.5 to 0.8	0.8 to 1.5	0.8 to 1.7	0.8 to 1.7
C		0.6 to 0.8	0.9 to 1.2	1.2 to 1.6	1.8 to 2.5

Reflow-soldering

Type		042	063	105	107	212	316	325	432
Size	L	0.4	0.6	1.0	1.6	2.0	3.2	3.2	4.5
	W	0.2	0.3	0.5	0.8	1.25	1.6	2.5	3.2
A		0.15 to 0.25	0.20 to 0.30	0.45 to 0.55	0.8 to 1.0	0.8 to 1.2	1.8 to 2.5	1.8 to 2.5	2.5 to 3.5
B		0.15 to 0.20	0.20 to 0.30	0.40 to 0.50	0.6 to 0.8	0.8 to 1.2	1.0 to 1.5	1.0 to 1.5	1.5 to 1.8
C		0.15 to 0.30	0.25 to 0.40	0.45 to 0.55	0.6 to 0.8	0.9 to 1.6	1.2 to 2.0	1.8 to 3.2	2.3 to 3.5

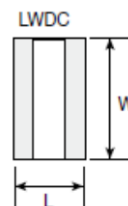
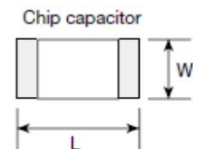
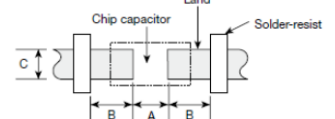
Note : Recommended land size might be different according to the allowance of the size of the product.

●LWDC: Recommended land dimensions for reflow-soldering

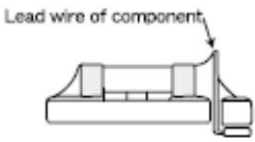
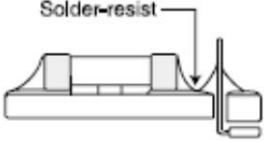
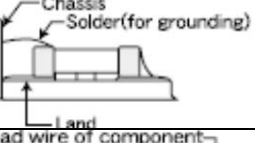
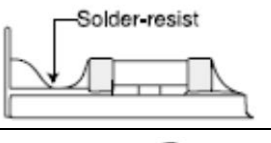
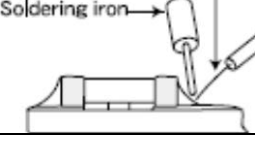
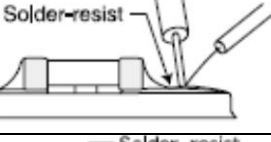
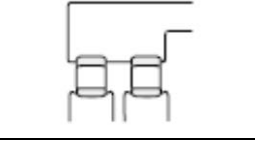
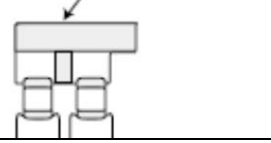
(unit: mm)

Type		105	107	212
Size	L	0.52	0.8	1.25
	W	1.0	1.6	2.0
A		0.18 to 0.22	0.25 to 0.3	0.5 to 0.7
B		0.2 to 0.25	0.3 to 0.4	0.4 to 0.5
C		0.9 to 1.1	1.5 to 1.7	1.9 to 2.1

Land patterns for PCBs



(2) Examples of good and bad solder application

Items	Not recommended	Recommended
Mixed mounting of SMD and leaded components		
Component placement close to the chassis		
Hand-soldering of leaded components near mounted components		
Horizontal component placement		

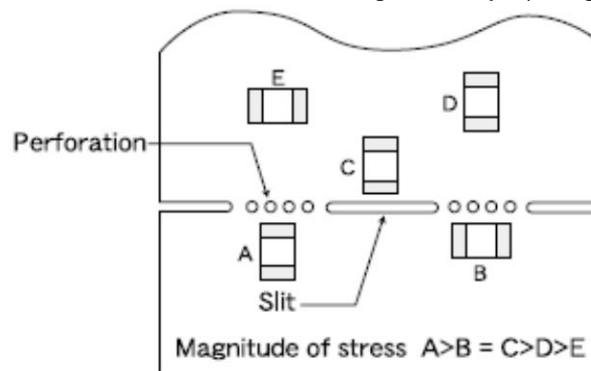
◆Pattern configurations (Capacitor layout on PCBs)

1-1. The following is examples of good and bad capacitor layouts ; capacitors shall be located to minimize any possible mechanical stresses from board warp or deflection.

Items	Not recommended	Recommended
Deflection of board		

Place the product at a right angle to the direction of the anticipated mechanical stress.

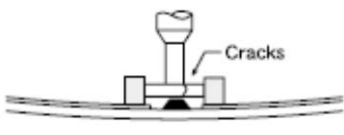
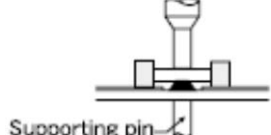
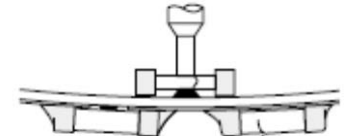
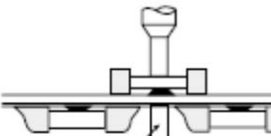
1-2. The amount of mechanical stresses given will vary depending on capacitor layout. Please refer to diagram below.



1-3. When PCB is split, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, please consider the PCB, split methods as well as chip location.

3. Mounting

Precautions	◆Adjustment of mounting machine - When capacitors are mounted on PCB, excessive impact load shall not be imposed on them. - Maintenance and inspection of mounting machines shall be conducted periodically. ◆Selection of Adhesives - When chips are attached on PCBs with adhesives prior to soldering, it may cause capacitor characteristics degradation unless the following factors are appropriately checked : size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, please contact us for further information.
	◆Adjustment of mounting machine - When the bottom dead center of a pick-up nozzle is too low, excessive force is imposed on capacitors and causes damages. To avoid this, the following points shall be considerable. - The bottom dead center of the pick-up nozzle shall be adjusted to the surface level of PCB without the board deflection. - The pressure of nozzle shall be adjusted between 1 and 3 N static loads. - To reduce the amount of deflection of the board caused by impact of the pick-up nozzle, supporting pins or back-up pins shall be used on the other side of the PCB. The following diagrams show some typical examples of good and bad pick-up nozzle placement:
Technical considerations	

Items	Not recommended	Recommended
Single-sided mounting		
Double-sided mounting		

2. As the alignment pin is worn out, adjustment of the nozzle height can cause chipping or cracking of capacitors because of mechanical impact on the capacitors.
To avoid this, the monitoring of the width between the alignment pins in the stopped position, maintenance, check and replacement of the pin shall be conducted periodically.

◆ Selection of Adhesives

Some adhesives may cause IR deterioration. The different shrinkage percentage of between the adhesive and the capacitors may result in stresses on the capacitors and lead to cracking. Moreover, too little or too much adhesive applied to the board may adversely affect components. Therefore, the following precautions shall be noted in the application of adhesives.

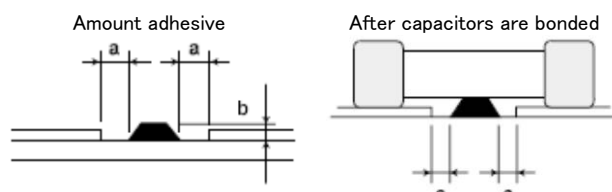
(1) Required adhesive characteristics

- The adhesive shall be strong enough to hold parts on the board during the mounting & solder process.
- The adhesive shall have sufficient strength at high temperatures.
- The adhesive shall have good coating and thickness consistency.
- The adhesive shall be used during its prescribed shelf life.
- The adhesive shall harden rapidly.
- The adhesive shall have corrosion resistance.
- The adhesive shall have excellent insulation characteristics.
- The adhesive shall have no emission of toxic gasses and no effect on the human body.

(2) The recommended amount of adhesives is as follows;

[Recommended condition]

Figure	212/316 case sizes as examples
a	0.3mm min
b	100 to 120 μ m
c	Adhesives shall not contact land



4. Soldering

◆ Selection of Flux

Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use;

- Flux used shall be less than or equal to 0.1 wt% (in Cl equivalent) of halogenated content. Flux having a strong acidity content shall not be applied.
- When shall capacitors are soldered on boards, the amount of flux applied shall be controlled at the optimum level.
- When water-soluble flux is used, special care shall be taken to properly clean the boards.

Precautions

◆ Soldering

Temperature, time, amount of solder, etc. shall be set in accordance with their recommended conditions.

Sn-Zn solder paste can adversely affect MLCC reliability.

Please contact us prior to usage of Sn-Zn solder.

◆ Selection of Flux

- When too much halogenated substance (Chlorine, etc.) content is used to activate flux, or highly acidic flux is used, it may lead to corrosion of terminal electrodes or degradation of insulation resistance on the surfaces of the capacitors.
- Flux is used to increase solderability in wave soldering. However if too much flux is applied, a large amount of flux gas may be emitted and may adversely affect the solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system.
- Since the residue of water-soluble flux is easily dissolved in moisture in the air, the residues on the surfaces of capacitors in high humidity conditions may cause a degradation of insulation resistance and reliability of the capacitors. Therefore, the cleaning methods and the capability of the machines used shall also be considered carefully when water-soluble flux is used.

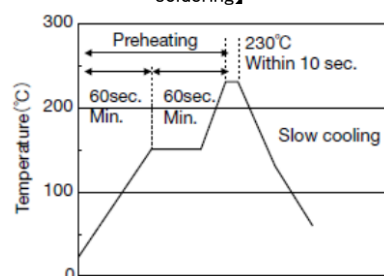
Technical considerations

◆ Soldering

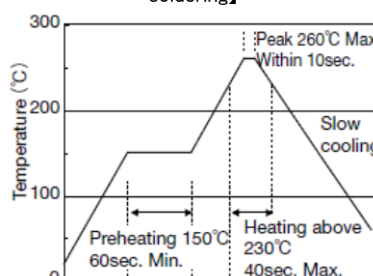
- Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling.
- Therefore, the soldering must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.
- Preheating : Capacitors shall be preheated sufficiently, and the temperature difference between the capacitors and solder shall be within 100 to 130°C.
- Cooling : The temperature difference between the capacitors and cleaning process shall not be greater than 100°C.

[Reflow soldering]

【Recommended conditions for eutectic soldering】

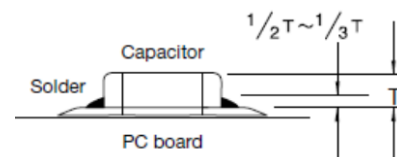


【Recommended condition for Pb-free soldering】



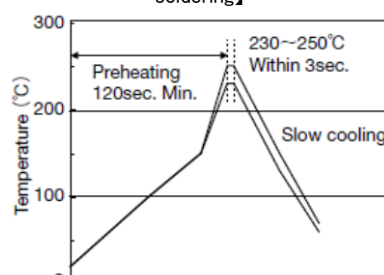
Cautions

- ① The ideal condition is to have solder mass(fillet) controlled to 1/2 to 1/3 of the thickness of a capacitor.
- ② Because excessive dwell times can adversely affect solderability, soldering duration shall be kept as close to recommended times as possible.
- ③ Allowable number of reflow soldering : 2 times max.

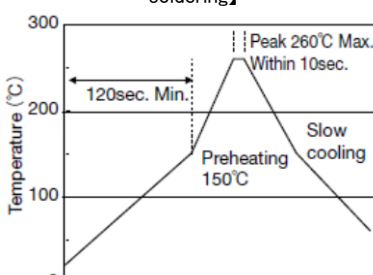


[Wave soldering]

【Recommended conditions for eutectic soldering】



【Recommended condition for Pb-free soldering】

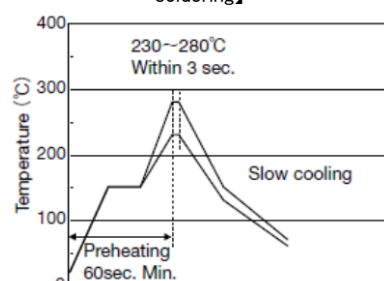


Cautions

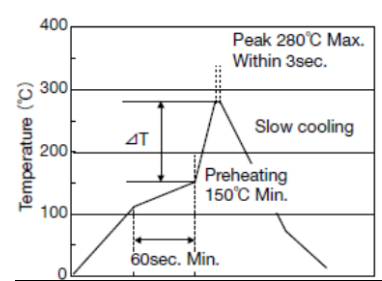
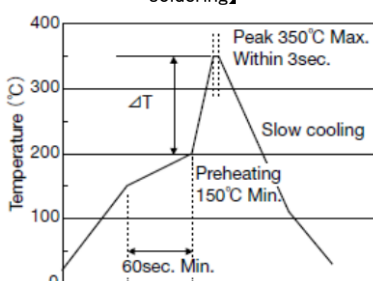
- ① Wave soldering must not be applied to capacitors designated as for reflow soldering only.
- ② Allowable number of wave soldering : 1 times max.

[Hand soldering]

【Recommended conditions for eutectic soldering】



【Recommended condition for Pb-free soldering】



Cautions

- ① Use a 50W soldering iron with a maximum tip diameter of 1.0 mm.
- ② The soldering iron shall not directly touch capacitors.
- ③ Allowable number of hand soldering : 1 times max.

5. Cleaning

◆Cleaning conditions

1. When PCBs are cleaned after capacitors mounting, please select the appropriate cleaning solution in accordance with the intended use of the cleaning. (e.g. to remove soldering flux or other materials from the production process.)
2. Cleaning condition shall be determined after it is verified by using actual cleaning machine that the cleaning process does not affect capacitor's characteristics.

Technical considerations

1. The use of inappropriate cleaning solutions can cause foreign substances such as flux residue to adhere to capacitors or deteriorate their outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance).
2. Inappropriate cleaning conditions (insufficient or excessive cleaning) may adversely affect the performance of the capacitors. In the case of ultrasonic cleaning, too much power output can cause excessive vibration of PCBs which may lead to the cracking of capacitors or the soldered portion, or decrease the terminal electrodes' strength. Therefore, the following conditions shall be carefully checked;
 Ultrasonic output : 20 W/l or less
 Ultrasonic frequency : 40 kHz or less

	Ultrasonic washing period : 5 min. or less
6. Resin coating and mold	
Precautions	1. With some type of resins, decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance. 2. When a resin's hardening temperature is higher than capacitor's operating temperature, the stresses generated by the excessive heat may lead to damage or destruction of capacitors. The use of such resins, molding materials etc. is not recommended.
7. Handling	
Precautions	◆Splitting of PCB 1. When PCBs are split after components mounting, care shall be taken so as not to give any stresses of deflection or twisting to the board. 2. Board separation shall not be done manually, but by using the appropriate devices. ◆Mechanical considerations Be careful not to subject capacitors to excessive mechanical shocks. (1) If ceramic capacitors are dropped onto a floor or a hard surface, they shall not be used. (2) Please be careful that the mounted components do not come in contact with or bump against other boards or components.
8. Storage conditions	
Precautions	◆Storage 1. To maintain the solderability of terminal electrodes and to keep packaging materials in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible. •Recommended conditions Ambient temperature : Below 30°C Humidity : Below 70% RH The ambient temperature must be kept below 40°C. Even under ideal storage conditions, solderability of capacitor is deteriorated as time passes, so capacitors shall be used within 6 months from the time of delivery. •Ceramic chip capacitors shall be kept where no chlorine or sulfur exists in the air. 2. The capacitance values of high dielectric constant capacitors will gradually decrease with the passage of time, so care shall be taken to design circuits. Even if capacitance value decreases as time passes, it will get back to the initial value by a heat treatment at 150°C for 1 hour.
Technical considerations	If capacitors are stored in a high temperature and humidity environment, it might rapidly cause poor solderability due to terminal oxidation and quality loss of taping/packaging materials. For this reason, capacitors shall be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.
※RCR-2335B (Safety Application Guide for fixed ceramic capacitors for use in electronic equipment) is published by JEITA. Please check the guide regarding precautions for deflection test, soldering by spot heat, and so on.	